


<b>Search Notes</b> 	<b>Application/Control No.</b> 10559915	<b>Applicant(s)/Patent Under Reexamination</b> RUIGROK ET AL.
	<b>Examiner</b> Alain L Bashore	<b>Art Unit</b> 1792

SEARCHED			
Class	Subclass	Date	Examiner
427	547,	12-19-08	ab
29	603.08; 603.14	12-19-08	ab

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (attached)	12-18-08	ab
eDAN inventor search	12-18-08	ab
previous search updated	6-8-09	ab

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/Alain L Bashore/ Primary Examiner.Art Unit 1792
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